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CONFIRMATION NO. 3930

FD Data Sheet

SERIAL NUMBER 09/251,988	FILING DATE 02/17/1999 RULE	CLASS 324	GROUP ART UNIT 2829	ATTORNEY DOCKET NO. Y0988-088
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APPLICANTS

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** CONTINUING DATA *****

This application is a CIP of 09/088,394,06/01/1998 PAT 6,300,780
which is a DIV of 08/754,869 11/22/1996 PAT 5,821,783
which is a CON of 08/055,485 04/30/1993 PAT 5,635,846

[initials]
[initials]
N/PT *J.-H.*

** FOREIGN APPLICATIONS *****

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 05/19/1999

Foreign Priority claimed	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no	STATE OR COUNTRY	SHEETS	TOTAL	INDEPENDENT
US USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after	NC	DRAWING 19	CLAIMS 10	CLAIMS 3
Verified and Acknowledged	<i>[Signature]</i> Attorney Customer's Signature Initials				

ADDRESS

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INTELLECTUAL PROPERTY LAW DEPT
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TITLE
STRUCTURAL DESIGN AND PROCESSES TO CONTROL PROBE POSITION ACCURACY IN A WAFER
TEST PROBE ASSEMBLY

<input type="checkbox"/> All Fees
<input type="checkbox"/> 1.16 Fees (Filing)